Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/511,493	HEO ET AL.
Examiner	Art Unit
DON N. VO	2611

	SEAR	CHED	
Class	Subclass	Date	Examiner
UPDATED		5/4/2006	DV
	-		
-			
,			

INT	ERFERENC	E SEARCH	IED
Class	Subclass	Date	Examiner
375	233, 350	5/5/2006	DV
	I		

(INCLUDING SEAR	HSIKATEG	1)
	DATE	EXMR
		<del> </del>
		<u> </u>
		1
=		
		<u> </u>
•		